

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the application of:

Tomohiro MIYASHITA

Appln. No.:

Filed: HERewith

For: MICROSCOPE OPTICAL SYSTEM AND MICROSCOPE OBJECTIVE  
LENS

\* \* \*

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

Sir:

Pursuant to 37 C.F.R. § 1.56, and without any  
assertion as to materiality or prior art effect, the  
documents listed on the attached Form PTO-1449 are hereby  
cited.

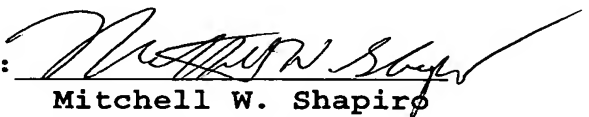
Documents AK and AL on the attached List were cited in  
the specification, on page 3, and their relevance is  
indicated therein.

Respectfully submitted,

MWS:sjk

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By:

  
Mitchell W. Shapiro  
Reg. No. 31,568

November 26, 2003

<b>FORM PTO-1449</b>				<b>Atty. Docket No.</b> <b>XA-9999</b>		<b>Appln. No.</b>	
<b><u>LIST OF DOCUMENTS CITED BY APPLICANT</u></b>							
				<b>Applicant</b> <b>Tomohiro MIYASHITA</b>			
				<b>Filing Date</b> <b>HEREWITH</b>		<b>Group</b>	
<b>U.S. PATENT DOCUMENTS</b>							
<b>Examiner Initial</b>		<b>Document Number</b>	<b>Date</b>	<b>Name</b>	<b>Class</b>	<b>Sub-class</b>	<b>Filing Date</b>
	AA	<b>6,320,702</b>	<b>11/20/01</b>	<b>Yonezawa</b>	<b>359</b>	<b>686</b>	
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
<b>FOREIGN PATENT DOCUMENTS</b>							
<b>Examiner Initial</b>		<b>Document Number</b>	<b>Date</b>	<b>Country</b>	<b>Class</b>	<b>Sub-class</b>	<b>Translation</b>
	AJ	<b>2000-171721</b>	<b>06/23/00</b>	<b>Japan</b> <b>(Abstract Only)</b>			<b>Abstract</b>
	AK	<b>2001-166215</b>	<b>06/22/01</b>	<b>Japan</b> <b>(Abstract Only)</b>			<b>Abstract</b>
	AL	<b>09-033818</b>	<b>02/07/97</b>	<b>Japan</b> <b>(Abstract Only)</b>			<b>Abstract</b>
	AM						
	AN						
	AO						
<b>OTHER</b> (including author, title, date, pertinent pages, etc.)							
	AP						
	AQ						
	AR						
<b>Examiner</b>				<b>Date Considered</b>			
<b>EXAMINER:</b> Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.							